

Notice of References Cited	Application/Control No. 10/601,626	Applicant(s)/Patent Under Reexamination JIEN, LEE-WEN	
	Examiner Mark A. Williams	Art Unit 3676	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,529,201 A	06-1996	Tallent et al.	220/298
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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